

Errata

**CC2755x10 SimpleLink™ Wireless MCU Device**

**Revision F**

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**ABSTRACT**

This document describes the known exceptions to functional specifications (advisories) of the CC2755x10 SimpleLink™ device.

This document supports the following devices:

- CC2755R105E0WRHAR
  - CC2755P105E0WRHAR
  - CC2755R105E0YCJR
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# 1 Advisories Matrix

Table 1-1 lists all advisories, modules affected, and the applicable silicon revisions.

**Table 1-1. Advisories Matrix**

MODULE	DESCRIPTION	SILICON REVISIONS AFFECTED
		F
ADC	<a href="#">Advisory ADC_08</a> —ADC BUSY bit not cleared in repeat single, sequence, and repeat sequence conversion modes	Yes
ADC	<a href="#">Advisory ADC_09</a> —ADC can have random conversion errors.	Yes
BATMON	<a href="#">Advisory BATMON_01</a> —Incorrect temperature measurement	Yes
BATMON	<a href="#">Advisory BATMON_02</a> —Spurious temperature update interrupts from BATMON in standby	Yes
SYS	<a href="#">Advisory SYS_204</a> —SysTimer may not always generate a compare event when previously programmed with a value	Yes
SYS	<a href="#">Advisory SYS_206</a> —The RF phase jumps during HFXT amplitude compensation and HFXT amplitude control	Yes
SYS	<a href="#">Advisory SYS_207</a> —Standby entry may not be gated if the FLTSETTLED bit is read too soon	Yes
APU	<a href="#">Advisory APU_201</a> —APU Data memory write operation fails	Yes
UDMA	<a href="#">Advisory UDMA_01</a> —μDMA write response to a peripheral's single request can be missed	Yes
RADIO	<a href="#">Advisory RADIO_05</a> —Radio write operation fails	Yes

## 2 Nomenclature, Package Symbolization, and Revision Identification

### 2.1 Device and Development Support—Tool Nomenclature

To designate the stages in the product development cycle, Texas Instruments™ assigns prefixes to the part numbers of all SimpleLink Wireless devices. Each SimpleLink Wireless part number has one of two prefixes: CC or XC. These prefixes represent evolutionary stages of product development from engineering prototypes (XC) through fully qualified production devices (CC).

Device development evolutionary flow:

**XC** Experimental device that is not necessarily representative of the final device's electrical specifications and may not use production assembly flow.

**CC** Production version of the silicon die that is fully qualified.

XC devices are shipped against the following disclaimer:

"Developmental product is intended for internal evaluation purposes."

Production devices have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI's standard warranty applies.

Predictions show that prototype devices (X) have a greater failure rate than the standard production devices. Texas Instruments recommends that these devices not be used in any production system because their expected end-use failure rate is still undefined. Only qualified production devices are to be used.

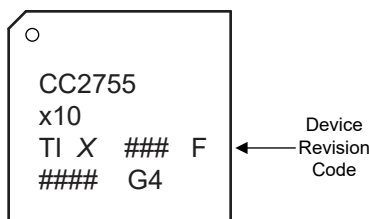
### 2.2 Devices Supported

This document supports the following devices:

- CC2755R105E0WRHAR
- CC2755P105E0WRHAR
- CC2755R105E0YCJR

### 2.3 Package Symbolization and Revision Identification

[Package Symbolization](#) and [Table 2-1](#) describe package symbolization and the device revision code.



**Figure 2-1. Package Symbolization**

**Table 2-1. Revision Identification**

Device Revision Code	Silicon Revision
F	PG2.1

The device marking includes the part number CC2755x, where x denotes the power level of the device. ##### is the lot trace code. Optionally, 'X' following the TI letters indicates an experimental device. G4 is the environmental classification.

### 3 Advisories

<b>ADC_08</b>	<b><i>ADC BUSY bit not cleared in repeat single, sequence, and repeat sequence conversion modes</i></b>
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<b>Revisions Affected</b>	F
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<b>Description</b>	When the ADC is configured in repeat single, sequence, or repeat sequence conversion modes with trigger policy as trigger next in the MEMCTLx register, software attempting to stop the conversion sequence by clearing the ENC bit does not clear the BUSY bit in the STATUS register. In the case of sequence conversion mode with trigger next policy, the BUSY bit is cleared at the end of the conversion sequence.
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<b>Workaround</b>	<p>To stop the conversions and to clear the BUSY bit in the above-mentioned ADC operating scenario, the following software sequence can be followed.</p> <ol style="list-style-type: none"><li>1. Write CTL0.ENC = 0</li><li>2. Change CTL1.TRIGSRC to SOFTWARE</li><li>3. Write CTL1.SC=1</li></ol>
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## ADC\_09 *ADC can have random conversion errors.*

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**Revisions Affected** F

**Description** ADC can have errors at a rate as high as 1 in 400 million ADC conversions. When a conversion error occurs, the error results in a jump in the digital output of the ADC without a corresponding change in the ADC input voltage, otherwise known as a 'sparkle code'. The magnitude of the jump is 64 LSBs higher or lower than the expected ADC output when ADC is used in a 12-bit resolution setting. The magnitude of the jump decreases to  $\pm 16$  LSBs for 10-bit resolution and  $\pm 4$  LSBs when set to 8-bit resolution.

**Workaround** The error rate can be reduced to 1 error in 100 billion ADC conversions by setting ADC.DEBUG1:CTRL[10:9] bits high. Other software workarounds, such as a best-out-of-three, where out of three consecutive samples, the one with the highest standard deviation is discarded and the other two averaged to generate the ADC output, can also be considered.

Software averaging of 16 consecutive ADC outputs decreases the deviation of the ADC output to  $\pm 4$  LSBs when set to 12-bit resolution.

This workaround would be incorporated into future releases of the SimpleLink™ Low Power F3 software development kit (SDK).

**BATMON\_01**      *Incorrect temperature measurement*

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**Revisions Affected**    F

**Description**            BATMON can report incorrect temperatures when hysteresis is enabled. To prevent potential incorrect temperature reports, the user must always disable BATMON hysteresis.

**Workaround**            Hysteresis is controlled by the PMUD.CLT[2] HYST\_EN bit.

Hysteresis is enabled by default (reset value = 1) and, therefore, must actively be disabled during boot.

Hysteresis can be disabled by clearing the PMUD.CLT[2] HYST\_EN bit using the following command:

```
HWREG( PMUD_BASE + PMUD_O_CTL ) = ( PMUD_CTL_CALC_EN |  
PMUD_CTL_MEAS_EN )
```

This workaround is incorporated into the SimpleLink™ Low Power F3 software development kit (SDK) version 9.11 and newer.

## BATMON\_02 *Spurious temperature update interrupts from BATMON in standby.*

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Revisions Affected F

**Description** BATMON can issue spurious temperature update interrupts when PMUD.EVENT.TEMP\_UPDATE is used as a wake-up source from standby.

**Workaround** Instead of using PMUD.EVENT.TEMP\_UPDATE as the wake-up source, PMUD.EVENT.TEMP\_OVER\_UL (current temperature over a set upper limit) or PMUD.EVENT.TEMP\_BELOW\_LL (current temperature below a set lower limit) shall be considered.

When using PMUD.EVENT.TEMP\_OVER\_UL or PMUD.EVENT.TEMP\_BELOW\_LL as wake-up interrupts, these are the other settings that have to be enabled:

- Select GLDO as the source for VDDR regulation by setting PMCTL.VDDRCTL.SELECT to 0x0.

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### Note

**This causes a slight increase in standby power consumption. Please check the 'Power Consumption – Power Modes' section of the data sheet for exact details.**

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- Set SYS0.TMUTE4.RECHCOMPREFLVL to 0x2
- Set SYS0.TMUTE5.GLDOISSET to 0x1E

This workaround would be incorporated into future releases of SimpleLink™ Low Power F3 software development kit (SDK).

<b>SYS_204</b>	<b><i>SysTimer may not always generate a compare event when previously programmed with a value.</i></b>
<b>Revisions Affected</b>	F
<b>Description</b>	SysTimer does not always generate a compare event during the initialization/sync up phase, when SysTimer has previously been programmed with a value.
<b>Workaround</b>	Wait to program SysTimer until SYSTIM.STATUS.SYNCUP is cleared. This workaround is incorporated into the SimpleLink™ Low Power F3 software development kit (SDK) version 9.11 and newer.

<b>SYS_206</b>	<b><i>The RF phase jumps during HFXT amplitude compensation and HFXT amplitude control.</i></b>
<b>Revisions Affected</b>	F
<b>Description</b>	The RF phase jumps during HFXT amplitude compensation and HFXT amplitude control. This issue only applies after the start-up of the device is complete, and then later programmatically adjusting the cap array values while using HFXT. If the cap array values are set during startup, this issue is not seen.
<b>Workaround</b>	The setting or modification of cap array steps should only be done during start-up and before any RF operations. Do not modify the cap array steps dynamically during run-time after that point. The Q1 and Q2 cap array steps can be modified in SysConfig.

<b>SYS_207</b>	<b><i>Standby entry may not be gated if the FLTSETTLED bit is read too soon.</i></b>
<b>Revisions Affected</b>	F
<b>Description</b>	Standby entry may not be gated if attempted before the LFINC filter settles and is read too soon. This issue is not seen when using LFXT.
<b>Workaround</b>	<p>To workaround this, when using LFOSC:</p> <ol style="list-style-type: none"><li>1. Clear both the interrupts.</li><li>2. Check for CKMD.RIS.HFXTGOOD.</li><li>3. Check for CKMD.RIS.LFTICK.</li><li>4. Check for FLTSETTLED.</li></ol> <p>Standby entry should be triggered only when the LFINC filter has settled, which can be confirmed by reading the memory masked register (MMR) CKMD.LFCLKSTAT.FLTSETTLED bit.</p> <p>Alternatively, LFXT can be used, and this can be avoided. This workaround is incorporated into the SimpleLink™ Low Power F3 software development kit (SDK) version 9.11 and newer.</p>

<b>APU_201</b>	<b><i>APU data memory write operation fails.</i></b>
<b>Revisions Affected</b>	F
<b>Description</b>	APU Data memory write operation fails if two write operations occur back-to-back.
<b>Workaround</b>	Customers must always use the TI APU driver to access APU data memory. This workaround is incorporated into the SimpleLink™ Low Power F3 software development kit (SDK) version 9.11 and newer.

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**UDMA\_01**      ***μDMA write response to a peripheral's single request can be missed.***

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**Revisions Affected**   F**Details**

μDMA responds to single and burst requests from peripherals. In case the write access(es) from μDMA is(are) intercepted by the interconnect write buffers due to arbitration loss, the peripheral can raise a second spurious single or burst request. Since the μDMA responds to the second request after the peripheral's FIFO gets full with earlier write buffer contents, the second write(s) is(are) ignored by the peripheral and get(s) missed. This issue is seen only during data transfers via μDMA TX channels. This issue is not seen on the μDMA RX channels, since the read path through the interconnect does not include write buffers.

**Workaround**

μDMA SETBURST is configured to use BURST requests.

μDMA arbitration size is 2.

The TX FIFO level trigger is set to  $\leq 1/4$  empty.

This workaround is incorporated into the SimpleLink™ Low Power F3 software development kit (SDK) version 9.11 and newer.

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**RADIO\_05**      *Radio write operation fails.*

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**Revisions Affected**   F

**Details**      Radio write operation fails if two write operations occur back-to-back.

**Workaround**      The RCL (Radio Control Layer) must always be used to interface with the radio.  
This workaround is incorporated into the SimpleLink™ Low Power F3 software development kit (SDK) version 9.11 and newer.

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